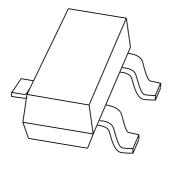
# **DISCRETE SEMICONDUCTORS**

# DATA SHEET



# **BAT754 series**Schottky barrier (double) diodes

Product data sheet Supersedes data of 1999 Aug 05 2003 Mar 25



NXP Semiconductors Product data sheet

# Schottky barrier (double) diodes

# **BAT754** series

### **FEATURES**

- · Very low forward voltage
- · Guard ring protected
- · Small plastic SMD package
- Low diode capacitance.

### **APPLICATIONS**

- Ultra high-speed switching
- Voltage clamping
- · Protection circuits
- · Blocking diodes
- Low power consumption applications, e.g. hand-held applications.

### **DESCRIPTION**

Planar Schottky barrier diodes encapsulated in a SOT23 small plastic SMD package. Low forward voltage selection of the BAT54 series. Single diodes and double diodes with different pinning are available.

# MARKING

TYPE NUMBER	MARKING CODE <sup>(1)</sup>
BAT754	2K*
BAT754A	2L*
BAT754C	2M*
BAT754S	2N*

## Note

1. \* = p: Made in Hong Kong.

\* = t : Made in Malaysia.\* = W : Made in China.

### **PINNING**

PIN	BAT754				
FIN		Α	С	S	
1	а	k <sub>1</sub>	a <sub>1</sub>	a <sub>1</sub>	
2	n.c.	k <sub>2</sub>	$a_2$	k <sub>2</sub>	
3	k	a <sub>1</sub> , a <sub>2</sub>	k <sub>1</sub> , k <sub>2</sub>	k <sub>1</sub> , a <sub>2</sub>	

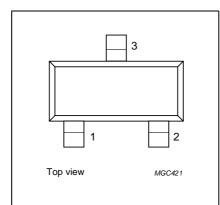


Fig.1 Simplified outline (SOT23) and pin configuration.

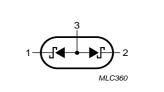


Fig.3 BAT754A diode configuration (symbol).

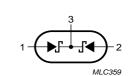


Fig.4 BAT754C diode configuration (symbol).

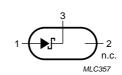


Fig.2 BAT754 single diode configuration (symbol).

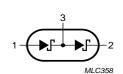


Fig.5 BAT754S diode configuration (symbol).

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# Schottky barrier (double) diodes

BAT754 series

# **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT		
Per diode	Per diode						
$V_R$	continuous reverse voltage		_	30	V		
I <sub>F</sub>	continuous forward current		_	200	mA		
I <sub>FRM</sub>	repetitive peak forward current	$t_p \le 1 \text{ s; } \delta \le 0.5$	-	300	mA		
I <sub>FSM</sub>	non-repetitive peak forward current	t = 8.3 ms half sinewave; JEDEC method	-	600	mA		
T <sub>stg</sub>	storage temperature		-65	+150	°C		
Tj	junction temperature		_	125	°C		
T <sub>amb</sub>	operating ambient temperature		-65	+125	°C		

# **ELECTRICAL CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT	
Per diode						
V <sub>F</sub>	forward voltage	see Fig.6				
		$I_F = 0.1 \text{ mA}$	_	200	mV	
		I <sub>F</sub> = 1 mA	_	260	mV	
		I <sub>F</sub> = 10 mA	_	340	mV	
		$I_F = 30 \text{ mA}$	_	420	mV	
		I <sub>F</sub> = 100 mA	600	_	mV	
I <sub>R</sub>	reverse current	V <sub>R</sub> = 25 V; note 1; see Fig.7	_	2	μΑ	
C <sub>d</sub>	diode capacitance	$f = 1 \text{ MHz}$ ; $V_R = 1 \text{ V}$ ; see Fig.8	_	10	pF	

### Note

# THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-a</sub>	thermal resistance from junction to ambient	note 1	500	K/W

# Note

1. Refer to SOT23 standard mounting conditions.

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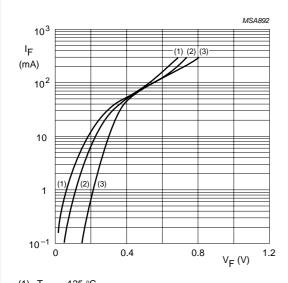
<sup>1.</sup> Pulse test:  $t_p$  = 300  $\mu$ s;  $\delta \le$  0.02.

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# Schottky barrier (double) diodes

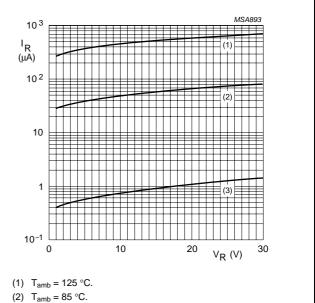
# BAT754 series

# **GRAPHICAL DATA**



- (1)  $T_{amb} = 125 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .

Fig.6 Forward current as a function of forward voltage; typical values.



- (3)  $T_{amb} = 25 \, ^{\circ}C$ .

Reverse current as a function of reverse voltage; typical values.

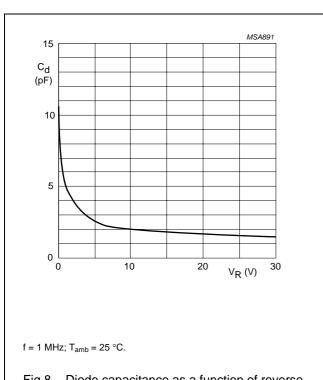


Fig.8 Diode capacitance as a function of reverse voltage; typical values.

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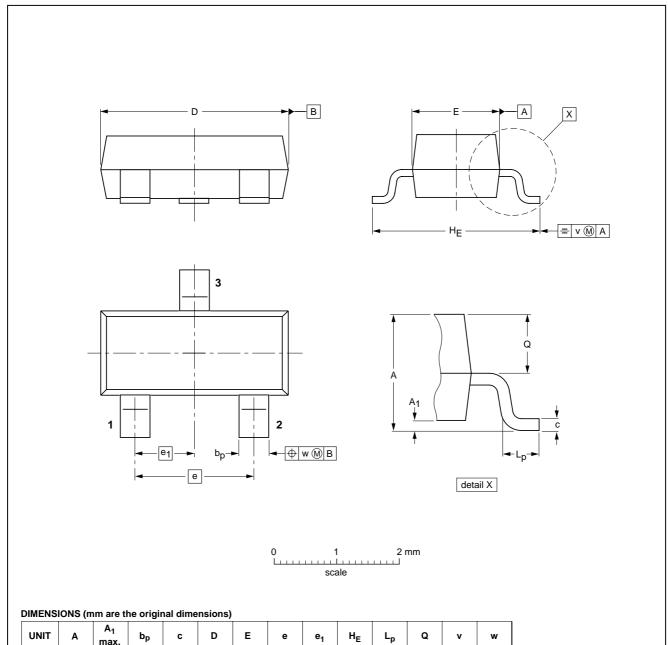
# Schottky barrier (double) diodes

# BAT754 series

# **PACKAGE OUTLINE**

Plastic surface mounted package; 3 leads

SOT23



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT23		TO-236AB				<del>-97-02-28</del> 99-09-13

1.9

0.45

0.55

0.1

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max.

0.48

0.38

0.15

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# Schottky barrier (double) diodes

# BAT754 series

### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

### **Notes**

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- 2. The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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# **Customer notification**

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# **Contact information**

For additional information please visit: http://www.nxp.com

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